

Reliability Prediction Assessment

 Article
 2320160
 from revision
 00

 Designation
 QUINT-DIODE/48DC/2X20/1X40

Device category 3 - electronical article

Р	rediction	done	bv:	pyfj02

at	40	°C with	100,00	% duty cycle
at		°C with		% duty cycle
at		°C with		% duty cycle
at		°C with		% duty cycle
at		°C with		% duty cycle
at		°C with		% duty cycle

based on	
SN 29500	

Environmental condition	
GB, GC - Ground Benign, Controlled	
	٦
	٦
	_

MTTF in h	MTTF in a
40000000	4566,21
-	-
-	-
-	~
-	-
-	12

failure rate in FIT (λ basis)
25